

RESTORING EFFICIENCY IN GEM SECTOR SEPARATIONS

Fabio Sauli

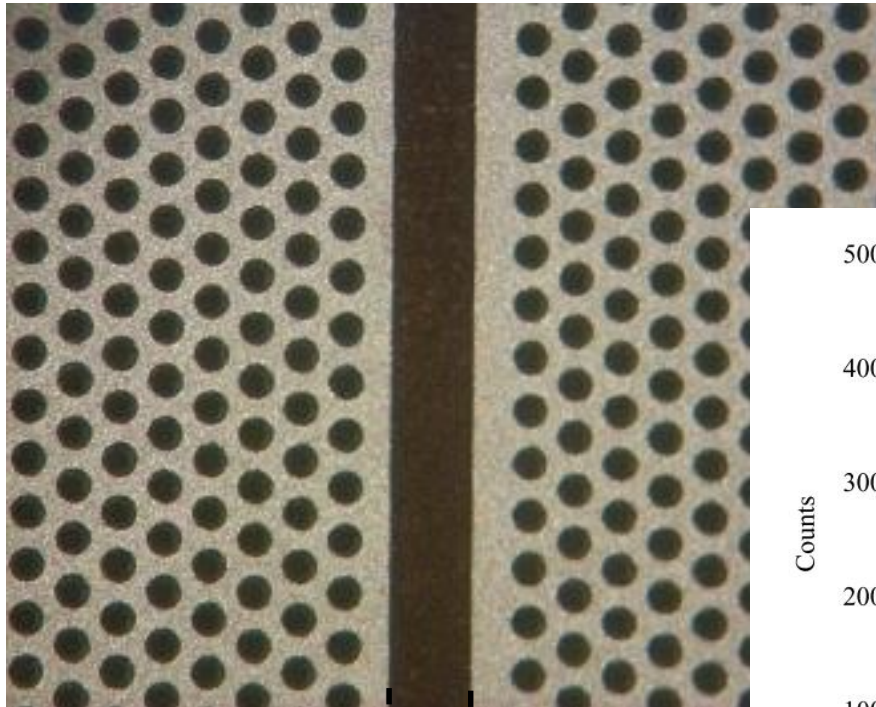
On behalf of the CERN GDD team

GEMs manufacture: Rui de Oliveira, Simon Williams (CERN-DT-EF)

DLC-coated Polymer: Yi Zhou (Hefei Univ.)

SECTORED GEMS TO REDUCE THE DISCHARGE ENERGY

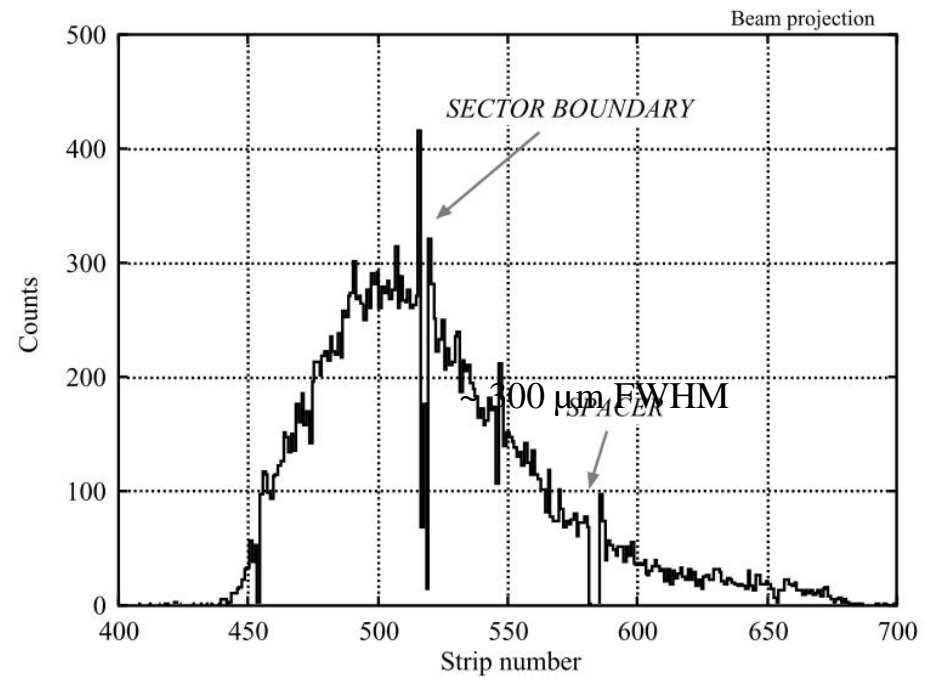
Maximum safe surface $\sim 100 \text{ cm}^2$



200 μm
COMPASS GEMs

FOR CHARGED PARTICLES;

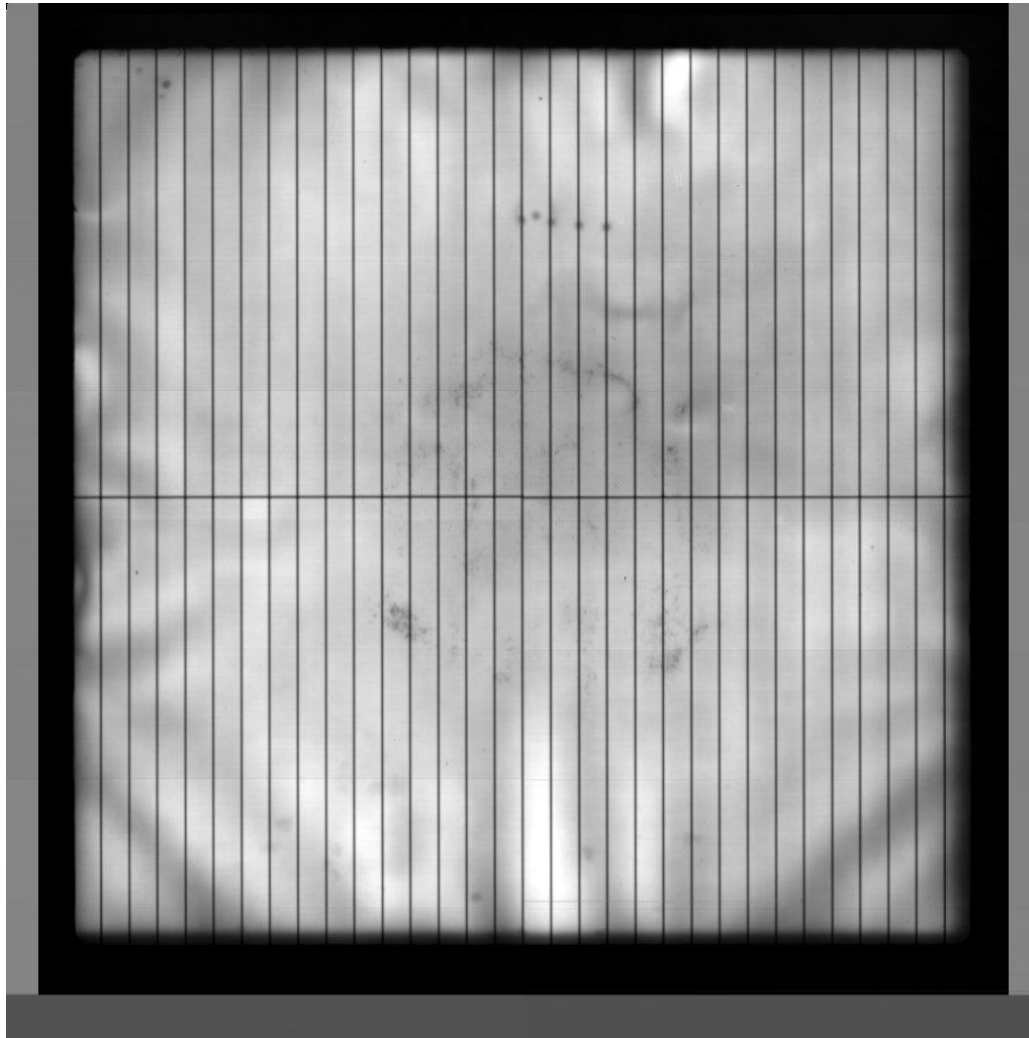
- Local distortions
- $\sim 1\%$ efficiency loss



TODAY'S TALK OF KONDO GNANVO: 60 SECTORS!

C. Altunbas et al, NIMA 490(2002)177

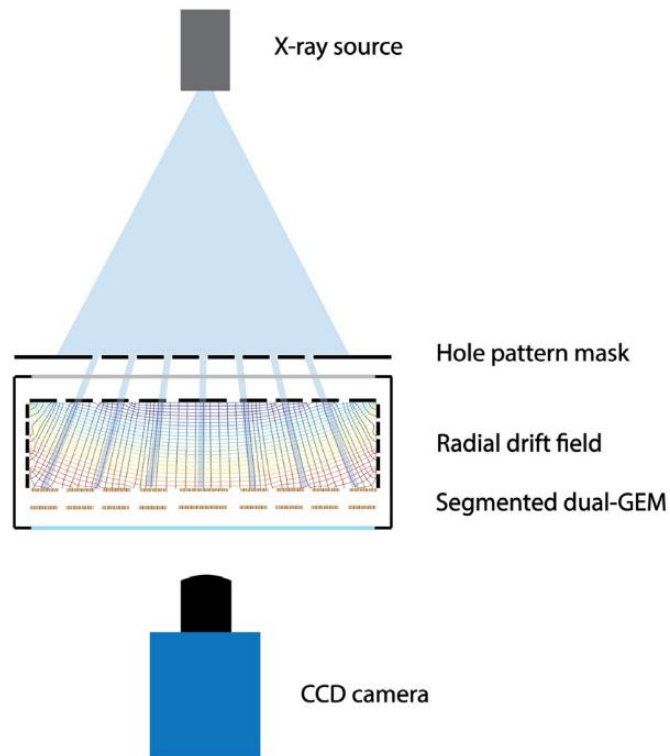
EFFECT OF SECTORS SEPARATION ON X-RAY DIGITAL RADIOGRAPHY FLOOD EXPOSURE



COURTESY OF Gunnar Norberg (C-RAD Imaging AG)

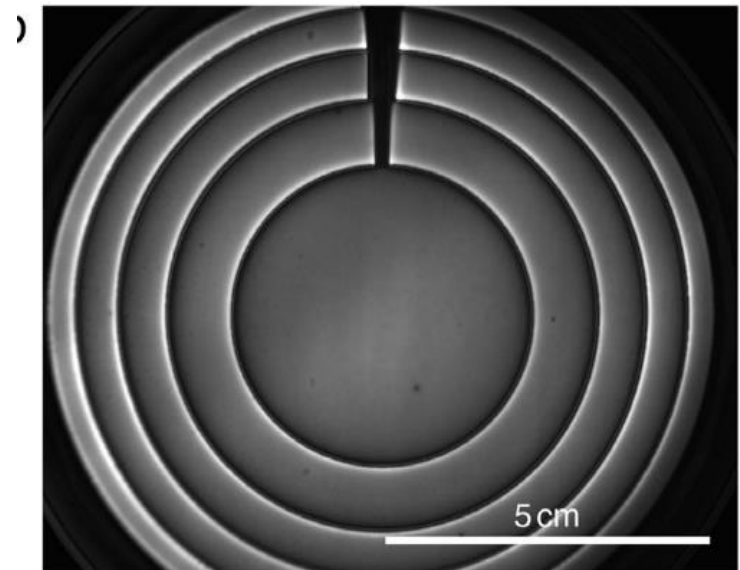
X-RAY DETECTION FOR CRYSTAL DIFFRACTION AND FLUORESCENCE ANALYSIS:

PLANISPHERICAL GEM PARALLAX-FREE FOR HIGH EFFICIENCY



Flood X-ray image:

Circular sectors at
graded potentials:



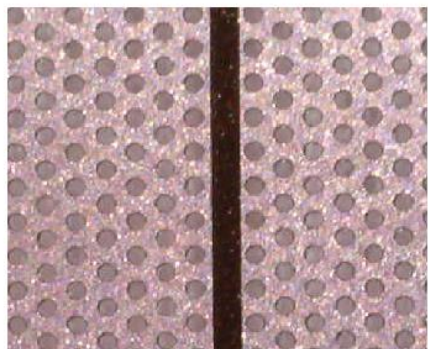
F. Brunbauer et al, NIMA 875 (2017) 16

THE SOLUTION: KEEP THE HOLES IN THE SECTOR SEPARATIONS
COMPARISON OF SECTORED GEMs

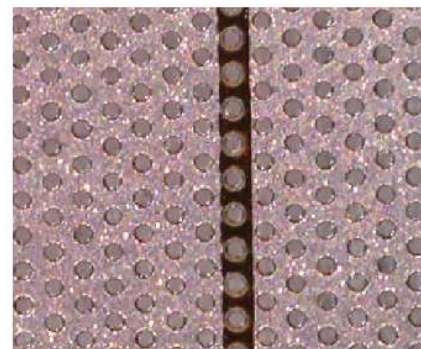
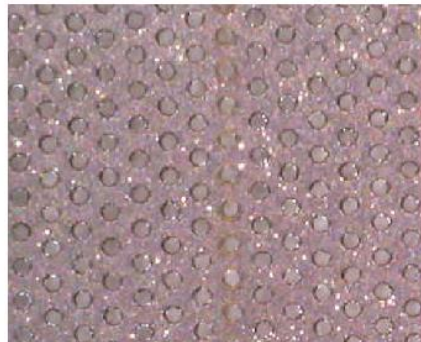
EQUAL HOLES DIAMETER EVERYWHERE

10x10 cm² GEMs with 100 μm sectors separations

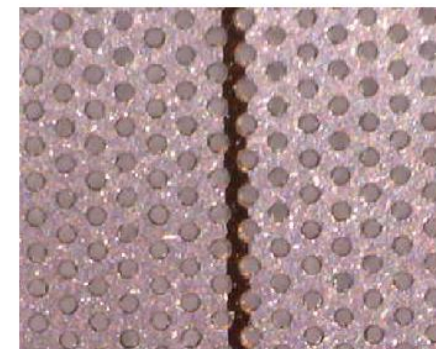
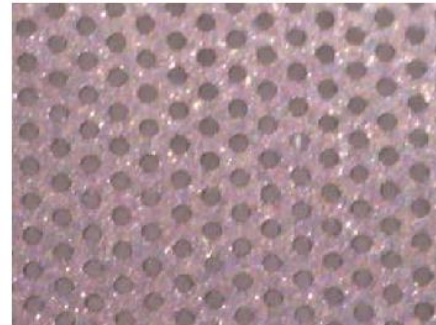
**Standard
Blank strip**



Full holes



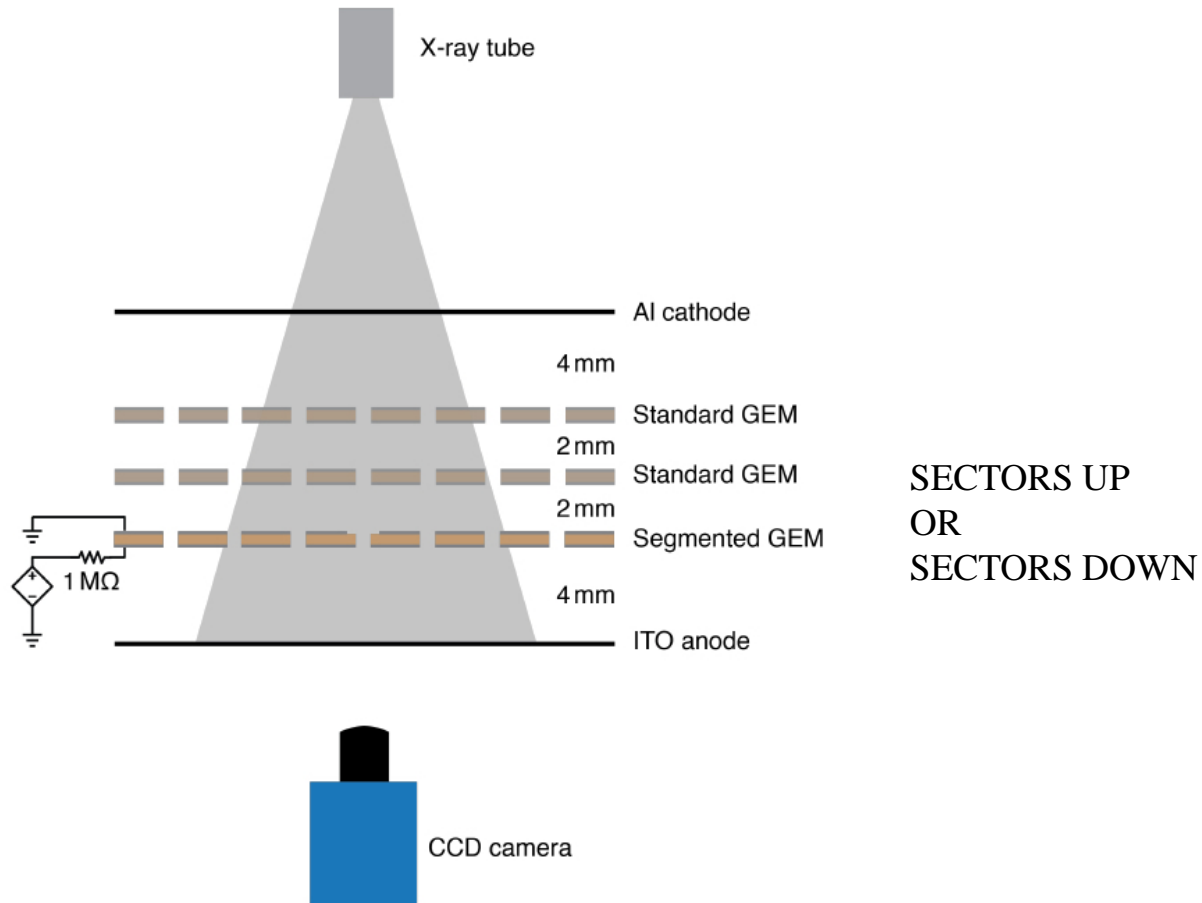
Random



CONTINUOUS
SIDE

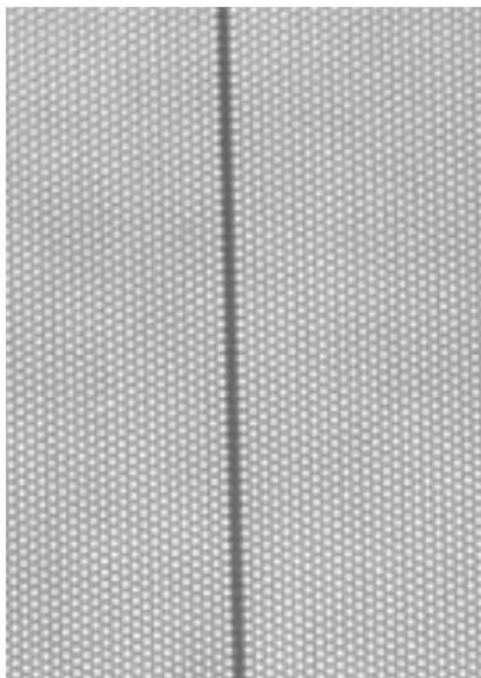
SECTORED
SIDE

MEASUREMENTS:
STANDARD GDD TRIPLE-GEM WITH OPTICAL READOUT
Ar-CF₄ (80-20)

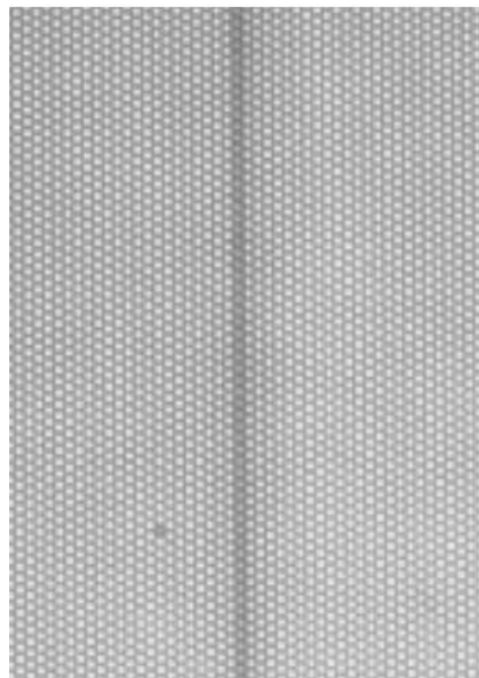


OPTICAL GEM IMAGES UNDER X-RAY FLOOD EXPOSURE SECTORS AT BOTTOM (TOWARDS CAMERA)

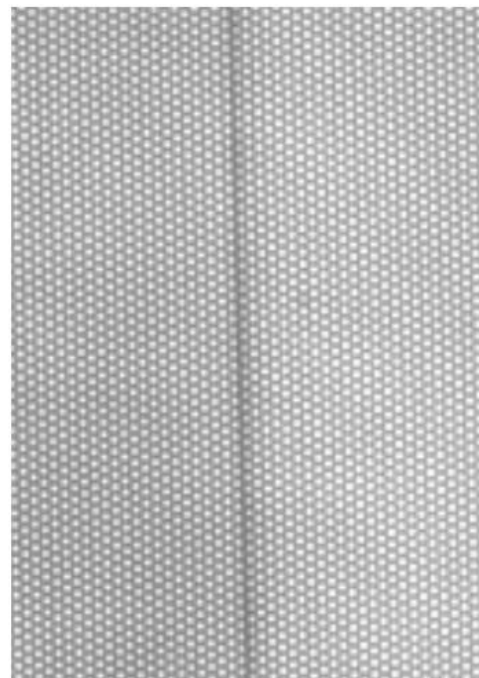
Standard GEM
Blank strip



Full holes

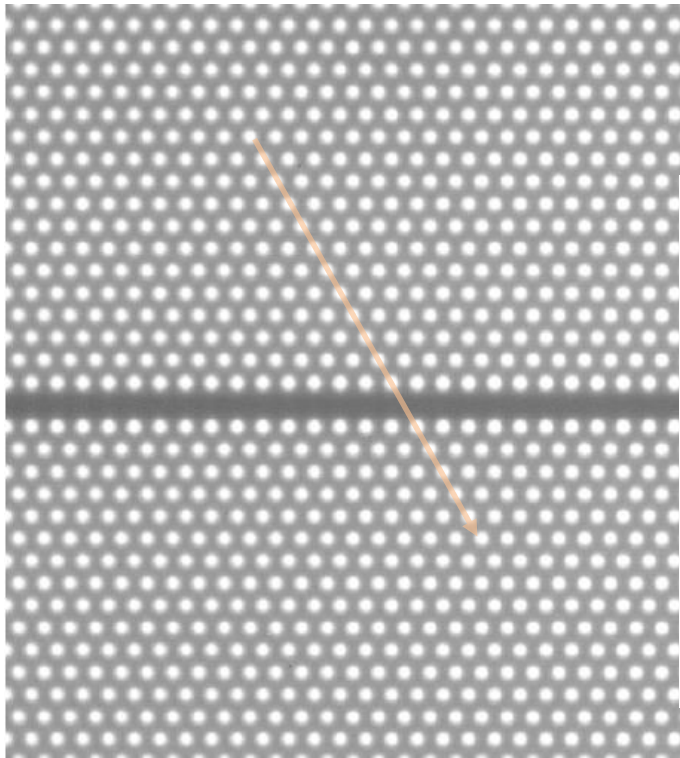


Random

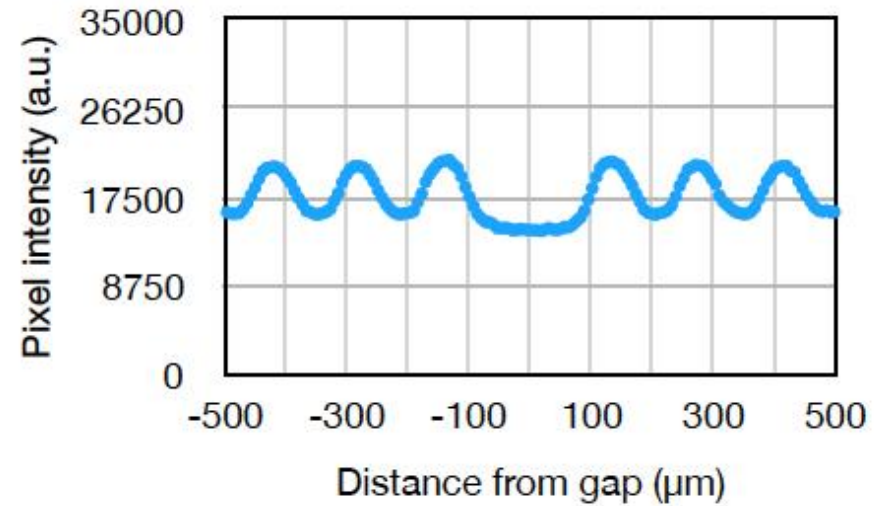


OPTICAL GEM READOUT: VERY GOOD RESOLUTION

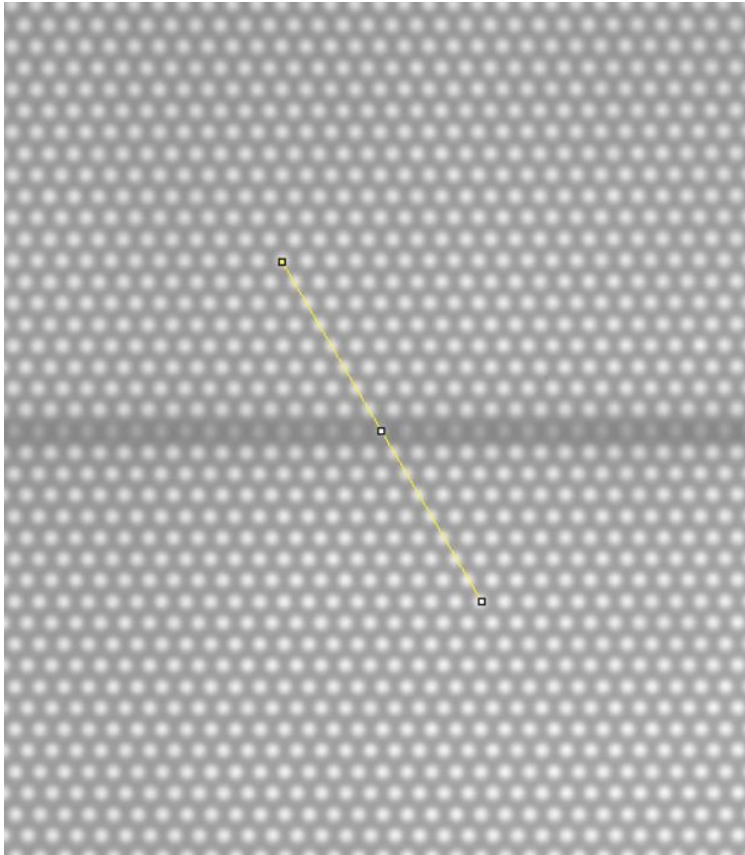
1-D PROFILES OF LIGHT INTENSITY



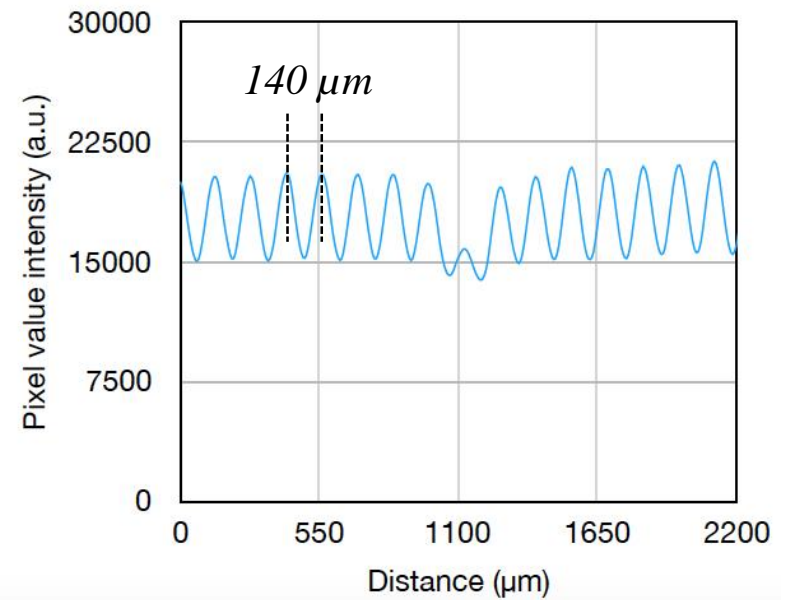
STANDARD “BLANK” SEPARATION



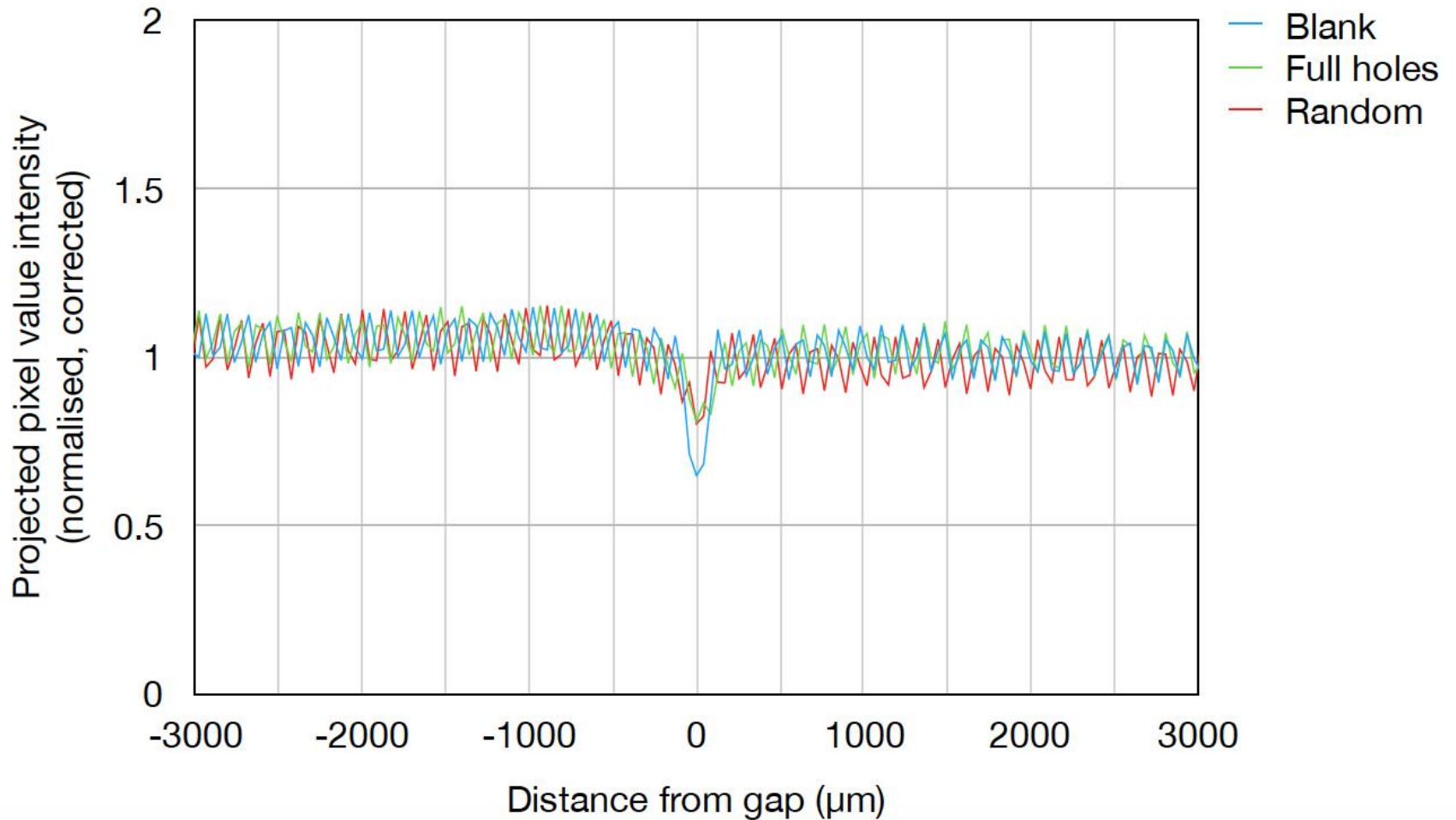
HIGHER RESOLUTION BACKGROUND SUBTRACTED



FULL HOLES SECTORS AT BOTTOM



COMPARISON OF SECTOR SEPARATIONS

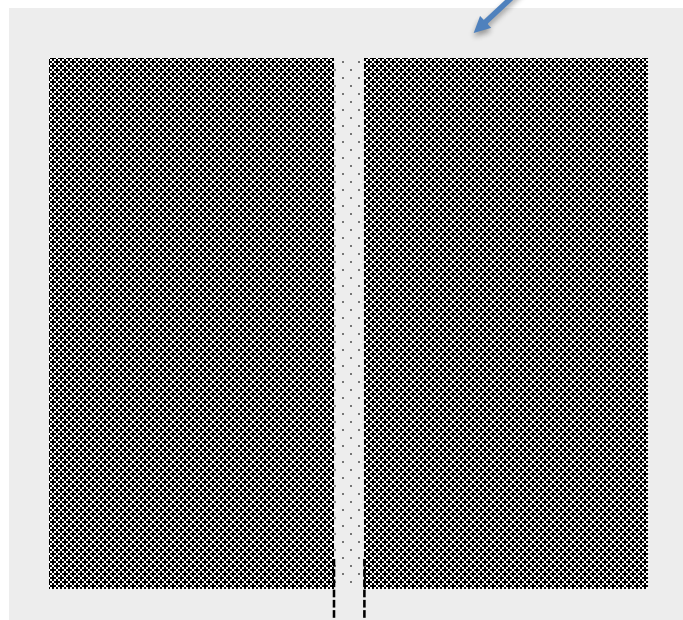


TO IMPROVE UNIFORMITY OF RESPONSE IN THE HOLES:

- RESISTIVE COATING OF THE SECTOR SEPARATIONS
- GEM MANUFACTURED ON DLC-COATED POLYMER

DLC-COATED POLYMER

NOMINAL $\rho \sim 10^9 \Omega / \text{square} \rightarrow 1 \text{ M}\Omega$ between sectors



100 μm

SECTOR SEPARATIONS:

100 μm x 10 cm : 10^3 squares

MEASURED: $\sim 3 \text{ M}\Omega$ between sectors

DLC GEMs AND μRWELL
(SEE RUI'S TALK IN W6)

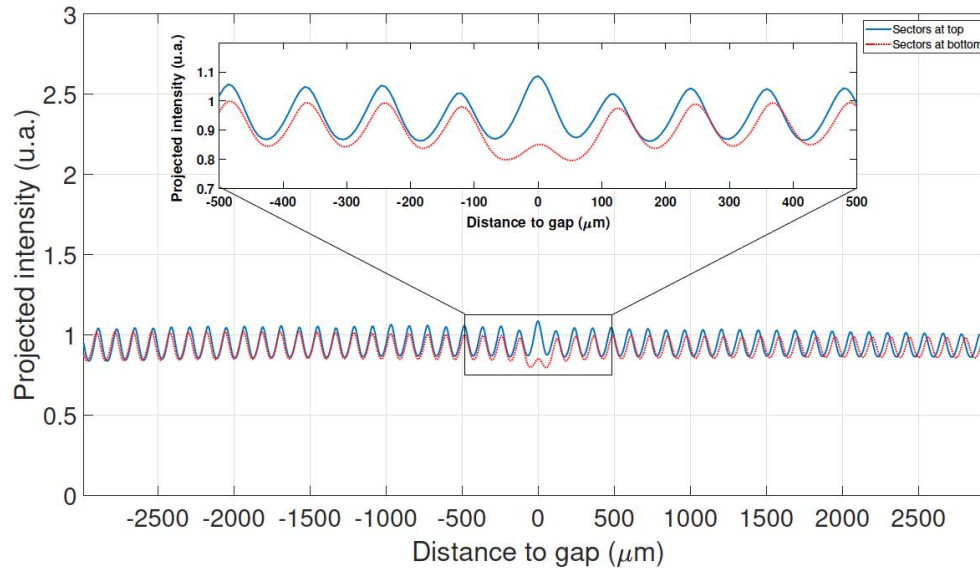
Yi Zhou et al, NIMA927 (2019) 31

3-SECTORS DLC GEM 10x10 cm². ~ 3 MΩ BETWEEN SECTORS

SECTORS AT BOTTOM



SECTORS AT TOP



— Sectors at top
— Sectors at bottom



SUMMARY:

- RESPONSE UNIFORMITY IN SECTORS SEPARATION RECOVERED WITH DLC GEM WITH SECTORS UP (TOWARDS CATHODE)
- DLC GEM MANUFACTURING PROCESS LABORIOUS (SAND BLASTING TO REMOVE DLC FROM HOLES) → SEE RUI'S PRESENTATION
- ONLY FEW % OF THE DLC EXPLOITED

OPEN QUESTIONS:

- IS THE GEM OPERATION AFFECTED BY THE PROCESS?
- WHY THERE IS A DIFFERENCE BETWEEN SECTORS DOWN-SECTORS UP? (HOLES ASYMMETRY... SEE ALSO YESTERDAY'S PRESENTATION BY Djunes Janssens)
- IS THERE ANOTHER WAY TO MAKE ONLY THE SEPARATION RESISTIVE?

DLC COATING AFTER MANUFACTURING PROBABLY DOES NOT WORK

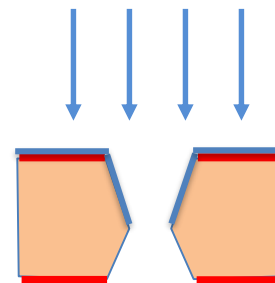
$10 \times 10 \text{ cm}^2 \rightarrow 10^6 \text{ holes}$ 1 hole $\sim 10 \text{ } \square$

DLC $10^{10} \text{ } \Omega/\square$ → 1 k Ω between electrodes

POOR ADHERENCE OF DLC TO COPPER

UNLESS...

IS DLC SPUTTERING DIRECTIONAL?



....*WORK TO BE CONTINUED!*